INSTRUMENT

SPALLATION NEUTRON SOURCE

EXTENDED Q-RANGE SMALL-ANGLE EQ-SANS NEUTRON SCATTERING DIFFRACTOMETER

The EQ-SANS Diffractometer is designed for the study of materials across length scales ranging from 0.1 to 100 nm. The high intensity provided by the EQ-SANS enables both

> high-throughput experiments and time-resolved experiments facilitated by the pulsed source of



SNS. EO-SANS enables measurements over a wide Q-range at a single instrument configuration, providing improved throughput. The high maximum O of the instrument allows both largescale and local structure to be studied by the instrument. The versatility of SANS makes EO-SANS broadly applicable to a wide range of materials from science and industry.

SPECIFICATIONS

Source- to-sample distance	14 m
Bandwidth	3–4.3 Å
Moderator	Coupled supercritical hydrogen
Integrated flux on sample	~10 ⁷ –10 ⁹ n/ cm ² /s
Q range	0.002 Å ⁻¹ < Q < 1.4 Å ⁻¹

Low-Angle Detector	
Sample- to-detector distance	1.3–9 m
Detector size	1 x 1 m
Detector resolution	5.5 x 4.3 mm

Status: Available to users

APPLICATIONS

Life science

- Solution structures of proteins, DNA, and other biological molecules and molecular complexes
- Protein-protein and protein-ligand interactions, kinase regulation
- Protein-membrane interaction
- Materials for drug delivery

Polymer and colloidal systems

- Block copolymers and dendrimers
- Micelles and emulsions
- Polyelectrolytes and ion distribution at solid-liquid interfaces

Materials science

- Simultaneous study of domain and crystalline structures
- Crystallization and precipitation
- Nanoparticles

Earth and environmental sciences

- Pore structure in soils
- Structure of geologic materials

FOR MORE INFORMATION, CONTACT

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